# DATA SHEET

**SAA4998H**

Field and line rate converter with noise reduction and embedded memory

Product specification

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**Philips**
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**Field and line rate converter with noise reduction and embedded memory**

**SAA4998H**

**CONTENTS**

Field and line rate converter with noise
reduction and embedded memory                                          SAA4998H

## 1  FEATURES

- Motion compensated frame rate upconversion of all $1f_H$ film and video standards up to 292 active input lines per field:
  - 50 Hz interlaced to 60 Hz progressive {(60p mode for LCD and Plasma Display (PDP) TV}
  - 50 Hz interlaced to 75 Hz interlaced {75i mode for jumbo screens, Projection TV (PTV)}
  - 50 Hz interlaced to 100 Hz interlaced (high-end 100 Hz TV)
  - 50 Hz interlaced to 50 Hz progressive (progressive scan TV and LCD and PDP TV)
  - 60 Hz interlaced to 60 Hz progressive (progressive scan TV and LCD and PDP TV)
  - 60 Hz interlaced to 90 Hz interlaced (jumbo screens, PTV)
  - 60 Hz interlaced to 120 Hz interlaced (multistandard high-end 100 Hz TV)
- 480 active lines (NTSC like) or 506 active lines in 50 Hz interlaced to 60 Hz progressive mode
- Motion compensated and Edge Dependent De-Interlacing (EDDI)[1]
- Motion estimated film mode detection
- Motion compensated movie judder cancellation:
  - 25 Hz 2 : 2 pull-down (PAL) to 60 Hz progressive or 75 Hz interlaced or 100 Hz interlaced or 50 Hz progressive
  - 30 Hz 2 : 2 pull-down (NTSC) to 60 Hz progressive or 90 Hz interlaced or 120 Hz interlaced
  - 24 Hz 3 : 2 pull-down (NTSC) to 60 Hz progressive or 90 Hz interlaced or 120 Hz interlaced
- Variable vertical sharpness enhancement
- High quality vertical zoom
- Motion compensated temporal noise reduction with after-imaging cancellation
- Split screen demonstration mode
- 2 Mbaud serial interface (SNERT)
- Embedded $2 \times 2.9$-Mbit DRAM
- Full 8-bit accuracy
- Memory buffer for Picture-In-Picture (PIP)
- Lead-free package.

## 2  GENERAL DESCRIPTION

The SAA4998H is a high performance video processor featuring Natural Motion™[2], for all global TV standards (PAL, NTSC and SECAM). It is used together with the picture improvement processor SAA4978H and SAA4979H.

The SAA4998H is an advanced version of the SAA4993H. By embedding the field memories it reduces the part count of the realized concept from 4 to 6 parts to only 2 parts and reduces the package size from a QFP160 to a QFP100.

The full FALCONIC mode uses full motion estimation and motion compensation on $^1/_4$ pixel accuracy to perform

- Frame rate upconversion
- Film mode detection
- Movie judder cancellation
- Dynamic Noise Reduction (DNR)
- Edge Dependent De-Interlacing (EDDI).

The motion compensated de-interlacer is improved with a new patented Edge Dependent De-Interlacing (EDDI) method. This avoids jagged edges of diagonal lines. The better de-interlacer leads to a significant better performance of progressive as well as interlaced output formats.

A 60 Hz progressive output frame rate can be generated for 50 Hz PAL sources to enable the use of 60 Hz LCD or PDP panels in PAL regions.

50 Hz interlaced to 75 Hz interlaced and 60 Hz interlaced to 90 Hz interlaced can be generated to achieve an increased number of lines and hence a reduction of line visibility for jumbo screens and PTV applications.

The embedded memory can be used to synchronize the main channel and the 2nd channel for PIP and double window applications. This avoids to add additional buffer memory devices to the application.

For demonstration purposes a split screen mode to show the Dynamic Noise Reduction (DNR) function, natural motion, and EDDI is available. The estimated motion vectors can be made visible by colour overlay mode.

The SAA4998H supports a Boundary Scan Test (BST) circuit in accordance with *"IEEE Std. 1149.1"*.

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(1) EDDI is protected with two patents of Koninklijke Philips Electronics N.V.

(2) Natural Motion is a trademark of Koninklijke Philips Electronics N.V.

## Field and line rate converter with noise reduction and embedded memory

## SAA4998H

### 2.1 Patent notice

Notice is herewith given that the subject integrated circuit uses one or more of the following US patents and that each of these patents may have corresponding patents in other jurisdictions.

US 4740842, US 5929919, US 6034734, US 5534946, US 5532750, US 5495300, US 5903680, US 5365280, US 5148269, US 5072293, US 5771074, and US 5302909.

### 2.2 Latch-up test

Latch-up test in accordance with *"Latch-up Resistance and Maximum Ratings Test; SNW-FQ-303"*; the SAA4998H fulfils the requirements.

### 3 QUICK REFERENCE DATA

| SYMBOL | PARAMETER | MIN. | TYP. | MAX. | UNIT |
|---|---|---|---|---|---|
| $V_{DDD}$ | core supply voltage (internal rail) | 1.65 | 1.8 | 1.95 | V |
| $V_{DDA}$ | analog supply voltage | | | | |
| $V_{DDM}$ | field memory supply voltage | | | | |
| $V_{DDS}$ | SRAM supply voltage | | | | |
| $V_{DDE}$ | external supply voltage (output pads) | 3.0 | 3.3 | 3.6 | V |
| $V_{DDP}$ | high supply voltage of internal field memories | | | | |
| $I_{DD}$ | sum of supply current | | | | |
| | at 1.8 V supply voltage pins | – | 180 | – | mA |
| | at 3.3 V supply voltage pins | – | 6 | – | mA |
| $f_{CLK}$ | operating clock frequency | – | 32 | 33.3 | MHz |
| $T_{amb}$ | ambient temperature | 0 | – | 70 | °C |

### 4 ORDERING INFORMATION

| TYPE NUMBER | PACKAGE | | | |
|---|---|---|---|---|
| | NAME | DESCRIPTION | VERSION | |
| SAA4998H | QFP100 | plastic quad flat package; 100 leads (lead length 1.95 mm); body $14 \times 20 \times 2.8$ mm | SOT317-2 | |
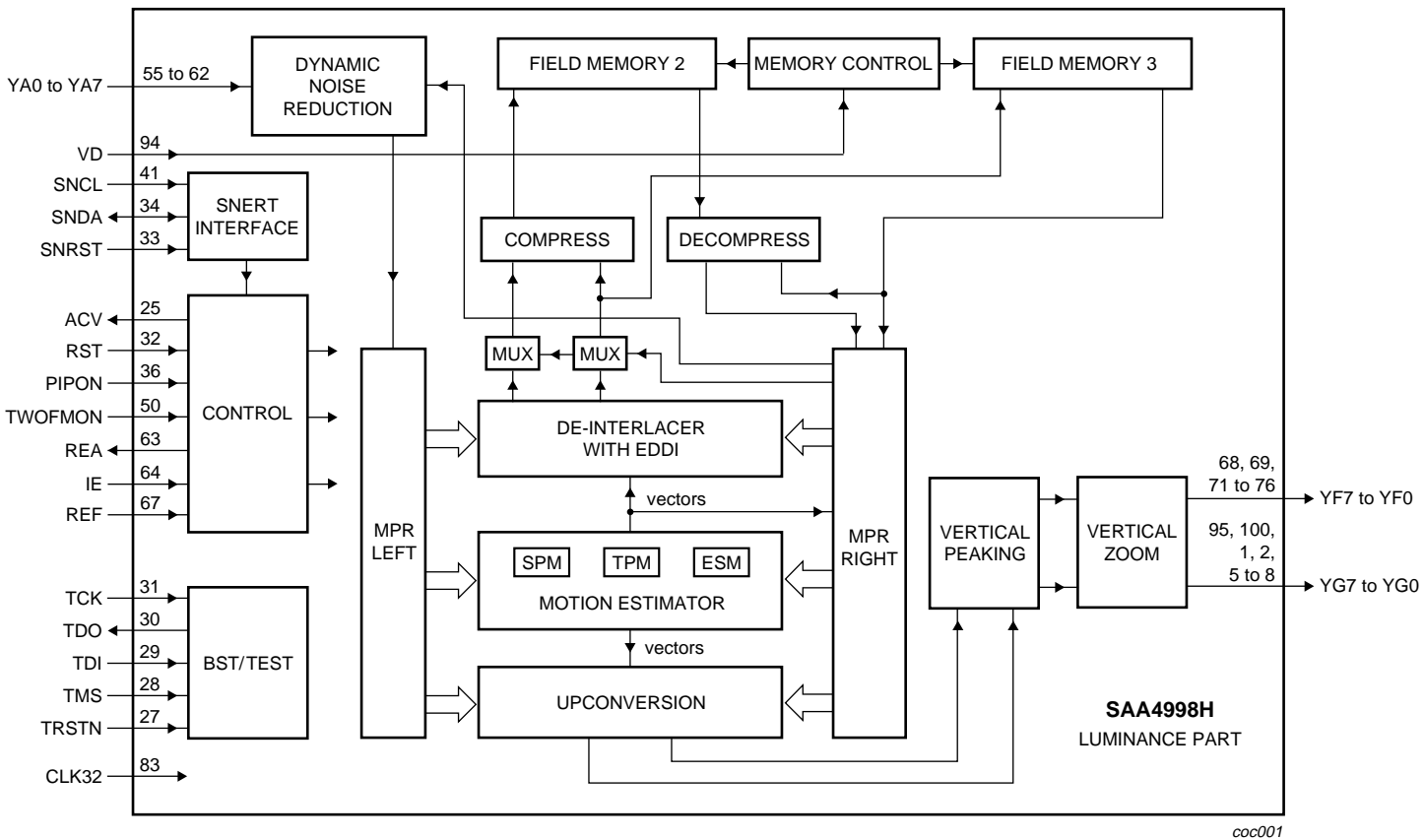
**5  BLOCK DIAGRAMS**



Fig.1  Block diagram luminance part in full FALCONIC mode.

coc001
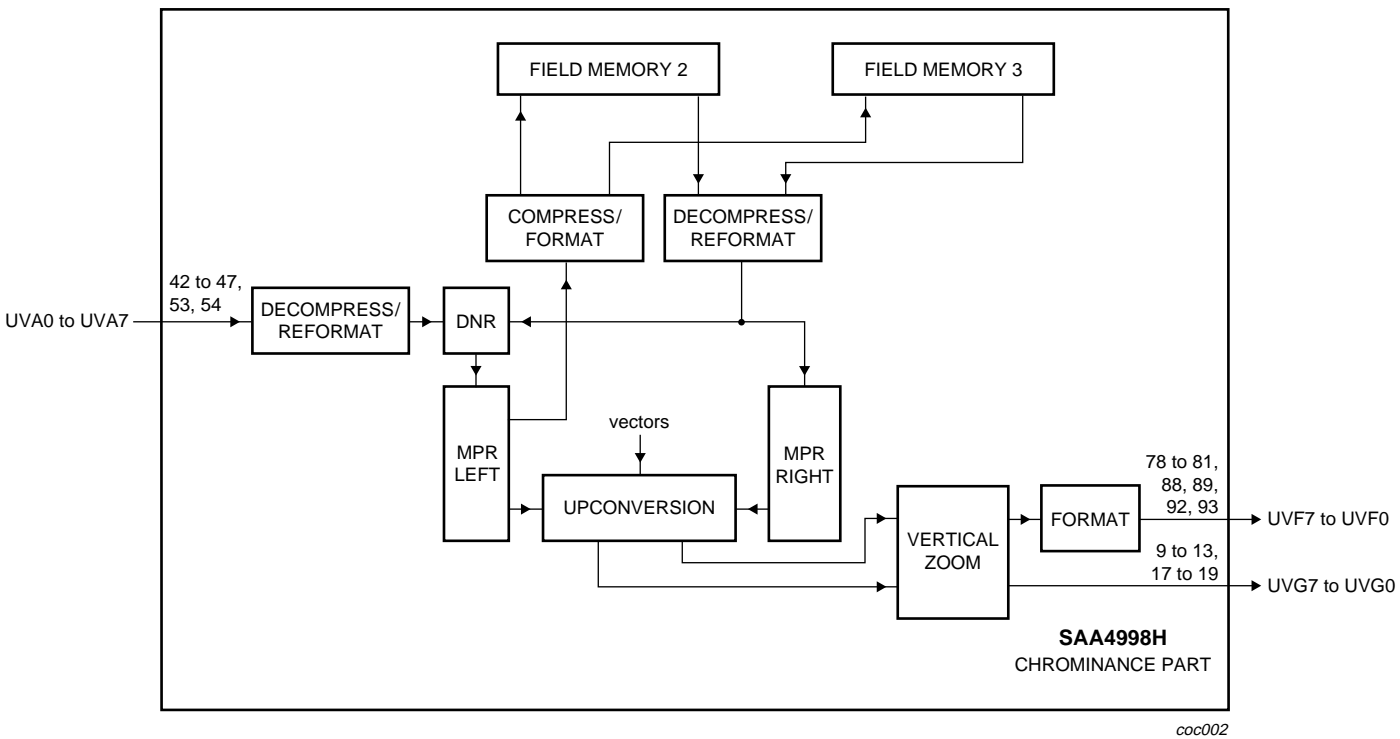
Fig.2  Block diagram chrominance part in full FALCONIC mode.

## 6 PINNING

| SYMBOL | PIN | TYPE | DESCRIPTION[(1)(2)(3)] |
|---|---|---|---|
| YG5/DPIP5 | 1 | output/input | PIP mode disabled: bus G luminance output bit 5;<br>PIP mode enabled: PIP data input bit 5 |
| YG4/DPIP4 | 2 | output/input | PIP mode disabled: bus G luminance output bit 4;<br>PIP mode enabled: PIP data input bit 4 |
| $V_{DDE}$ | 3 | supply | supply voltage of output pads (3.3 V) |
| $V_{SSE}$ | 4 | ground | ground of output pads |
| YG3/DPIP3 | 5 | output/input | PIP mode disabled: bus G luminance output bit 3;<br>PIP mode enabled: PIP data input bit 3 |
| YG2/DPIP2 | 6 | output/input | PIP mode disabled: bus G luminance output bit 2;<br>PIP mode enabled: PIP data input bit 2 |
| YG1/DPIP1 | 7 | output/input | PIP mode disabled: bus G luminance output bit 1;<br>PIP mode enabled: PIP data input bit 1 |
| YG0/DPIP0 | 8 | output/input | PIP mode disabled: bus G luminance output bit 0 (LSB);<br>PIP mode enabled: PIP data input bit 0 (LSB) |
| UVG7/QPIP7 | 9 | output | PIP mode disabled: bus G chrominance output bit 7 (MSB);<br>PIP mode enabled: PIP data output bit 7 (MSB) |
| UVG6/QPIP6 | 10 | output | PIP mode disabled: bus G chrominance output bit 6;<br>PIP mode enabled: PIP data output bit 6 |
| UVG5/QPIP5 | 11 | output | PIP mode disabled: bus G chrominance output bit 5;<br>PIP mode enabled: PIP data output bit 5 |
| UVG4/QPIP4 | 12 | output | PIP mode disabled: bus G chrominance output bit 4;<br>PIP mode enabled: PIP data output bit 4 |
| UVG3/QPIP3 | 13 | output | PIP mode disabled: bus G chrominance output bit 3;<br>PIP mode enabled: PIP data output bit 3 |
| n.c./LLC | 14 | input | PIP mode disabled: not connected;<br>PIP mode enabled: line locked clock signal for PIP mode |
| $V_{SSE}$ | 15 | ground | ground of output pads |
| n.c./SWCK2 | 16 | input | PIP mode disabled: not connected;<br>PIP mode enabled: serial write clock for PIP memory |
| UVG2/QPIP2 | 17 | output | PIP mode disabled: bus G chrominance output bit 2;<br>PIP mode enabled: PIP data output bit 2 |
| UVG1/QPIP1 | 18 | output | PIP mode disabled: bus G chrominance output bit 1;<br>PIP mode enabled: PIP data output bit 1 |
| UVG0/QPIP0 | 19 | output | PIP mode disabled: bus G chrominance output bit 0 (LSB);<br>PIP mode enabled: PIP data output bit 0 (LSB) |
| n.c./RSTW2 | 20 | input | PIP mode disabled: not connected;<br>PIP mode enabled: write reset clock for PIP memory |
| n.c./OIE2 | 21 | input | PIP mode disabled: not connected;<br>PIP mode enabled: output enable for PIP memory output QPIPx |
| n.c./IE2 | 22 | input | PIP mode disabled: not connected;<br>PIP mode enabled: input enable for PIP memory |
| $V_{DDP}$ | 23 | supply | high supply voltage of the internal field memories (3.3 V) |
| n.c./WE2 | 24 | input | PIP mode disabled: not connected;<br>PIP mode enabled: write enable for PIP memory |

| SYMBOL | PIN | TYPE | DESCRIPTION[1][2][3] |
|---|---|---|---|
| ACV/RE2 | 25 | output/input | PIP mode disabled: active video output;<br>PIP mode enabled: read enable for PIP memory |
| n.c./RSTR2 | 26 | input | PIP mode disabled: not connected;<br>PIP mode enabled: read reset for PIP memory |
| TRSTN | 27 | input | boundary scan test reset input (active LOW); with internal pull-up resistor |
| TMS | 28 | input | boundary scan test mode select input; with internal pull-up resistor |
| TDI | 29 | input | boundary scan test data input; with internal pull-up resistor |
| TDO | 30 | 3-state | boundary scan test data output |
| TCK | 31 | input | boundary scan test clock input; with internal pull-up resistor |
| RST | 32 | input | reset input; see Fig.4 |
| SNRST | 33 | input | SNERT bus reset input; with internal pull-down resistor |
| SNDA | 34 | input/output | SNERT bus data input and output; with internal pull-down resistor |
| $V_{DDE}$ | 35 | supply | supply voltage of output pads (3.3 V) |
| PIPON | 36 | input | PIP mode enable input |
| $V_{SSM}$ | 37 | ground | field memory ground |
| $V_{DDM}$ | 38 | supply | supply voltage of the internal field memories (1.8 V) |
| $V_{SSM}$ | 39 | ground | field memory ground |
| $V_{DDM}$ | 40 | supply | supply voltage of the internal field memories (1.8 V) |
| SNCL | 41 | input | SNERT bus clock input; with internal pull-down resistor |
| UVA0 | 42 | input | bus A chrominance input bit 0 (LSB) |
| UVA1 | 43 | input | bus A chrominance input bit 1 |
| UVA2 | 44 | input | bus A chrominance input bit 2 |
| UVA3 | 45 | input | bus A chrominance input bit 3 |
| UVA4 | 46 | input | bus A chrominance input bit 4 |
| UVA5 | 47 | input | bus A chrominance input bit 5 |
| $V_{DDD}$ | 48 | supply | core supply voltage (1.8 V) |
| $V_{SSD}$ | 49 | ground | core ground |
| TWOFMON | 50 | input | to be connected to ground |
| $V_{DDS}$ | 51 | supply | supply voltage of the internal SRAMs (1.8 V) |
| $V_{SSS}$ | 52 | ground | ground of the internal SRAMs |
| UVA6 | 53 | input | bus A chrominance input bit 6 |
| UVA7 | 54 | input | bus A chrominance input bit 7 (MSB) |
| YA0 | 55 | input | bus A luminance input bit 0 (LSB) |
| YA1 | 56 | input | bus A luminance input bit 1 |
| YA2 | 57 | input | bus A luminance input bit 2 |
| YA3 | 58 | input | bus A luminance input bit 3 |
| YA4 | 59 | input | bus A luminance input bit 4 |
| YA5 | 60 | input | bus A luminance input bit 5 |
| YA6 | 61 | input | bus A luminance input bit 6 |
| YA7 | 62 | input | bus A luminance input bit 7 (MSB) |
| REA | 63 | output | read enable output for bus A |

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| SYMBOL | PIN | TYPE | DESCRIPTION[1][2][3] |
|---|---|---|---|
| IE | 64 | input | input enable for PIP mode |
| $V_{DDD}$ | 65 | supply | core supply voltage (1.8 V) |
| $V_{SSD}$ | 66 | ground | core ground |
| REF | 67 | input | read enable input for bus F and G; note 4 |
| YF7 | 68 | output | bus F luminance output bit 7 (MSB) |
| YF6 | 69 | output | bus F luminance output bit 6 |
| $V_{SSE}$ | 70 | ground | ground of output pads |
| YF5 | 71 | output | bus F luminance output bit 5 |
| YF4 | 72 | output | bus F luminance output bit 4 |
| YF3 | 73 | output | bus F luminance output bit 3 |
| YF2 | 74 | output | bus F luminance output bit 2 |
| YF1 | 75 | output | bus F luminance output bit 1 |
| YF0 | 76 | output | bus F luminance output bit 0 (LSB) |
| $V_{DDE}$ | 77 | supply | supply voltage of output pads (3.3 V) |
| UVF7 | 78 | output | bus F chrominance output bit 7 (MSB) |
| UVF6 | 79 | output | bus F chrominance output bit 6 |
| UVF5 | 80 | output | bus F chrominance output bit 5 |
| UVF4 | 81 | output | bus F chrominance output bit 4 |
| $V_{SSE}$ | 82 | ground | ground of output pads |
| CLK32 | 83 | input | system clock input (32 MHz) |
| $V_{DDS}$ | 84 | supply | supply voltage of the internal SRAMs (1.8 V) |
| $V_{SSS}$ | 85 | ground | ground of the internal SRAMs |
| $V_{DDD}$ | 86 | supply | core supply voltage (1.8 V) |
| $V_{SSD}$ | 87 | ground | core ground |
| UVF3 | 88 | output | bus F chrominance output bit 3 |
| UVF2 | 89 | output | bus F chrominance output bit 2 |
| $V_{SSA}$ | 90 | ground | analog ground of the internal PLL |
| $V_{DDA}$ | 91 | supply | analog supply voltage of the internal PLL (1.8 V) |
| UVF1 | 92 | output | bus F chrominance output bit 1 |
| UVF0 | 93 | output | bus F chrominance output bit 0 (LSB) |
| VD | 94 | input | vertical display synchronization input (reset for field memories) |
| YG7/DPIP7 | 95 | output/input | PIP mode disabled: bus G luminance output bit 7 (MSB); PIP mode enabled: PIP data input bit 7 (MSB) |
| $V_{DDM}$ | 96 | supply | supply voltage of the internal field memories (1.8 V) |
| $V_{SSM}$ | 97 | ground | field memory ground |

Field and line rate converter with noise
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| SYMBOL | PIN | TYPE | DESCRIPTION[1][2][3] |
|--------|-----|------|---------------------|
| $V_{DDM}$ | 98 | supply | supply voltage of the internal field memories (1.8 V) |
| $V_{SSM}$ | 99 | ground | field memory ground |
| YG6/DPIP6 | 100 | output/input | PIP mode disabled: bus G luminance output bit 6;<br>PIP mode enabled: PIP data input bit 6 |

**Notes**

1. **Not used input pins should be connected to ground.**

2. Because of the noisy characteristic of the supply voltage of output pads ($V_{DDE}$), it is recommended not to connect $V_{DDE}$ directly at the high supply voltage of the intern field memories ($V_{DDP}$). All pins $V_{DDE}$ should be buffered as close as possible to the device. $V_{DDP}$ needs a low noise supply voltage, therefore, it is recommended that $V_{DDP}$ has to be separated from $V_{DDE}$ by an external filter structure. Because of the high working frequency of the device, it is also recommended to filter the core supply voltage ($V_{DDD}$). All pins $V_{DDD}$ should be buffered as close as possible to the device.

3. $V_{SSD}$, $V_{SSM}$ and $V_{SSS}$ are connected internally.

4. REF rising edge must be after rising edge of SNRST in order to be detected.

Field and line rate converter with noise
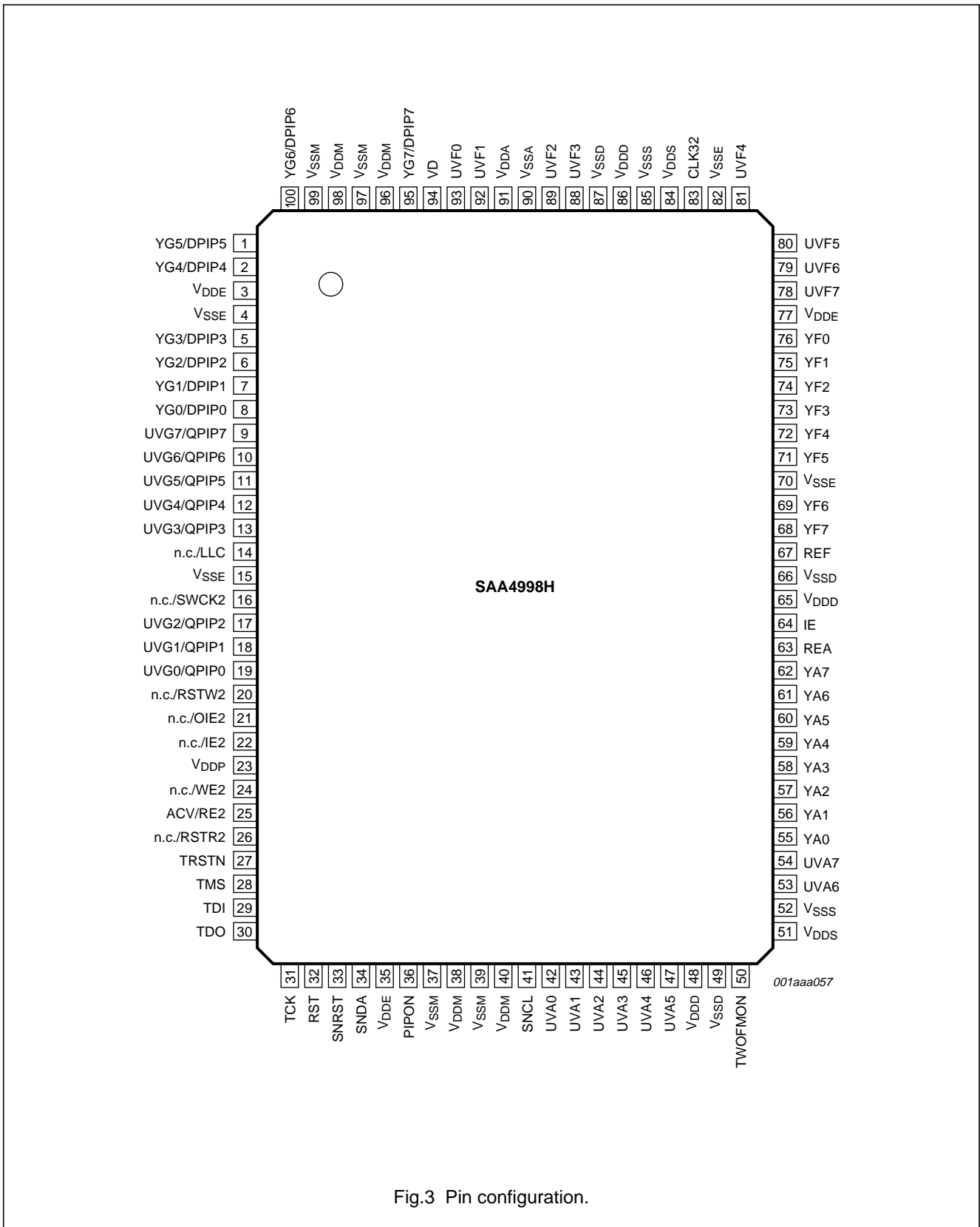reduction and embedded memory

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Fig.3 Pin configuration.

# 7 CONTROL REGISTER DESCRIPTION

| NAME | SNERT ADDRESS (HEX) | READ/ WRITE[1] | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 | DESCRIPTION[2] |
|---|---|---|---|---|---|---|---|---|---|---|---|
| **DNR/peaking/colour** | | | | | | | | | | | |
| **Kstep10** | 010 | write; S | | | | | | | | | |
| Kstep0 | | | | | | | X | X | X | X | set LUT value: k = $\frac{1}{16}$ if difference below (**0 to 15**) |
| Kstep1 | | | X | X | X | X | | | | | set LUT value: k = $\frac{1}{8}$ if difference below (**0 to 15**) |
| **Kstep32** | 011 | write; S | | | | | | | | | |
| Kstep2 | | | | | | | X | X | X | X | set LUT value: k = $\frac{2}{8}$ if difference below (**0 to 30 in multiples of 2**) |
| Kstep3 | | | X | X | X | X | | | | | set LUT value: k = $\frac{3}{8}$ if difference below (**0 to 30 in multiples of 2**) |
| **Kstep54** | 012 | write; S | | | | | | | | | |
| Kstep4 | | | | | | | X | X | X | X | set LUT value: k = $\frac{4}{8}$ if difference below (**0 to 60 in multiples of 4**) |
| Kstep5 | | | X | X | X | X | | | | | set LUT value: k = $\frac{5}{8}$ if difference below (**0 to 60 in multiples of 4**) |
| **Kstep76** | 013 | write; S | | | | | | | | | |
| Kstep6 | | | | | | | X | X | X | X | set LUT value: k = $\frac{6}{8}$ if difference below (**0, 8, 16, 24, 32, 40, 48, 56, 64, 72, 80, 88, 96, 104, 112 or 120**) |
| Kstep7 | | | X | X | X | X | | | | | set LUT value: k = $\frac{7}{8}$ if difference below (**0, 8, 16, 24, 32, 40, 48, 56, 64, 72, 80, 88, 96, 104, 112 or 120**) |
| **Gain_fix_y** | 014 | write; S | | | | | | | | | |
| FixvalY | | | | | | | X | X | X | X | set fixed Y value; used when FixY = 1 or in left part of split screen (**0, $\frac{1}{16}$ to $\frac{14}{16}$ or $\frac{16}{16}$**) |
| GainY | | | | X | X | X | | | | | set gain in difference signal for adaptive DNR Y ($\frac{1}{8}$, $\frac{1}{4}$, $\frac{1}{2}$, **1, 2 or 4**) |
| FixY | | | X | | | | | | | | select fixed Y (**adaptive or fixed**) (full screen) |
| **Gain_fix_uv** | 015 | write; S | | | | | | | | | |
| FixvalUV | | | | | | | X | X | X | X | set fixed UV value; used when FixUV = 1 or in left part of split screen (**0, $\frac{1}{16}$ to $\frac{14}{16}$ or $\frac{16}{16}$**) |
| GainUV | | | | X | X | X | | | | | set gain in difference signal for adaptive DNR UV ($\frac{1}{8}$, $\frac{1}{4}$, $\frac{1}{2}$, **1, 2 or 4**) |
| FixUV | | | X | | | | | | | | select fixed UV (**adaptive or fixed**) (full screen) |

| NAME | SNERT ADDRESS (HEX) | READ/WRITE[1] | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 | DESCRIPTION[2] |
|---|---|---|---|---|---|---|---|---|---|---|---|
| **Peak_Vcomp** | 016 | write; S | | | | | | | | | |
| VecComp | | | | | | | | X | X | X | set degree of horizontal vector compensation in Y DNR: (**0, $\frac{1}{8}$, $\frac{2}{8}$, $\frac{3}{8}$, $\frac{4}{8}$, $\frac{5}{8}$, $\frac{6}{8}$ or $\frac{7}{8}$**) of the vector |
| NoiseShape | | | | | | | X | | | | noise shaping enable; this bit is set to logic 1 after reset or power-up |
| PeakCoef | | | X | X | X | X | | | | | set vertical peaking level: (**0, +2, +3.5, +5, +6, x, x, x, x, x, x, x, x, −12, −6 or −2.5**) dB |
| **DNR_Colour_mode** | 017 | write; S | | | | | | | | | |
| ColourIn | | | | | | | | | X | X | select colour input format: (**4 : 1 : 1, 4 : 2 : 2, 4 : 2 : 2 DPCM or 4 : 2 : 2**) |
| ColourOut | | | | | | | | X | | | select colour output format: (**4 : 1 : 1 or 4 : 2 : 2**) |
| NrofFMs | | | | | | | X | | | | set number of field memories used for motion compensation: (**1 or 2**) |
| ColOvl | | | | | | X | | | | | select vector overlay on colour output: (**vector overlay or colour from video path**) |
| SlaveUVtoY | | | | | X | | | | | | slave UV noise reduction to K factor of Y: (**separate or slaved**) |
| DnrSplit | | | | X | | | | | | | select split screen mode for DNR: (**normal or split screen**) |
| DnrHpon | | | X | | | | | | | | switch DNR high-pass on (DNR only active on low frequent spectrum: (**all through DNR or high bypassed**) |
| **Vertical zoom** | | | | | | | | | | | |
| **Zoom1** | 018 | write; F | | | | | | | | | |
| ZoomSt98 | | | | | | | | | X | X | zoom line step bits 9 and 8; line step = vertical distance between successive output lines; usable range = 0 to 2 frame lines; resolution $\frac{1}{256}$ frame line |
| ZoomPo98 | | | | | X | X | | | | | zoom start position bits 9 and 8; start position = vertical position of the top display line; usable range = 1 to 3 frame lines; resolution $\frac{1}{256}$ frame line |
| **Zoom2** | 019 | write; F | | | | | | | | | |
| ZoomSt70 | | | X | X | X | X | X | X | X | X | zoom line step bits 7 to 0 (see above) |
| **Zoom3** | 01A | write; F | | | | | | | | | |
| ZoomPo70 | | | X | X | X | X | X | X | X | X | zoom start position bits 7 to 0 (see above) |

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| NAME | SNERT ADDRESS (HEX) | READ/ WRITE[1] | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 | DESCRIPTION[2] |
|---|---|---|---|---|---|---|---|---|---|---|---|
| **Zoom4** | 01B | write; F | | | | | | | | | |
| ZoomEnVal | | | | | | | X | X | X | X | zoom run in value = number of lines without zoom active (**0 to 15** lines) |
| ZoomDiVal | | | X | X | X | X | | | | | zoom run out value = number of lines without zoom active (−**8 to +7** lines) |
| **De-interlacer** | | | | | | | | | | | |
| **Proscan1** | 01C | write; S | | | | | | | | | |
| KlfLim | | | | | | | X | X | X | X | limitation of recursion factor in calculation of original line positions: (**1 to 16**); 1 limits to almost full recursion, 16 limits to no recursion |
| KlfOfs | | | X | X | X | X | | | | | The transfer curve of the de-interlacing filter coefficient is determined by the difference (Diff) between a line in the input field and the counterpart in the previous field shifted over the estimated motion vector. KlfOfs determines the bias of the transfer curve for the original input line, such that coefficient = KlfOfs + F(Diff), where the function F is calculated in the SAA4998H. The bias can take a value in the range (**0 to 15**), representing decreasing filter strength. |
| **Proscan2** | 01D | write; S | | | | | | | | | |
| PlfLim | | | | | | | X | X | X | X | limitation of recursion factor in calculation of interpolated line positions: (**1 to 16**); 1 limits to almost full recursion, 16 limits to no recursion |
| PlfOfs | | | X | X | X | X | | | | | see KlfOfs; this offset applies to interpolated lines |
| **Proscan3** | 01E | write; S | | | | | | | | | |
| PeakLim | | | | | | | X | X | X | X | Maximum that the peaked pixel is allowed to deviate from original pixel value: deviation (**0 to 30 in steps of 2**). Above this deviation, the peaked pixel is clipped to (original pixel + or − PeakLim). |
| DeiOfs | | | X | X | X | X | | | | | offset to bias between average and median in the initial de-interlacing, if the KplFad = MIX option is chosen |

| NAME | SNERT ADDRESS (HEX) | READ/ WRITE[1] | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 | DESCRIPTION[2] |
|---|---|---|---|---|---|---|---|---|---|---|---|
| **Proscan4** | 01F | write; F | | | | | | | | | |
| PlfThr | | | | | | | | X | X | X | Multiplier threshold at which to switch the lower limit of the filter coefficient for interpolated lines. Above this threshold, the differences corresponding to the two neighbouring lines are used as clipping parameters, below this threshold, the interpolated line difference is used as clipping level. This parameter can be used to optimize the de-interlacing quality in slowly moving edges; it is not likely to have effect if PlfLim is high. |
| AdRecOut | | | | | | | X | | | | select adaptive recursive or order statistic output (**order statistic or adaptive**) |
| ProDiv | | | | | X | X | | | | | Scaling factor to control the strength of the filtering for the interpolated lines. A value 0 means no scaling (normal filtering), while 3 means scaling by factor 8 (very strong filtering). This parameter can be used to adjust the de-interlacing to varying level of noise in the input picture; use higher scaling for higher noise. |
| KplOff | | | X | | | | | | | | disable all recursion in calculating pixels for frame memory (**recursive or non recursive**) |
| **Proscan5** | 0CB | write; S | | | | | | | | | |
| VecRbf | | | | | | | X | X | X | X | Roll back factor on vectors used for motion-compensated de-interlacing. Values **0 to 14** (on a scale of 16) indicate attenuation. A value of **15** indicates no attenuation. |
| FadDiv | | | | X | X | X | | | | | sensitivity scaling factor in transition from average to median in initial de-interlacing |
| KplFad | | | X | | | | | | | | chooses between majority selection and median/average mix for initial de-interlacing (**majority or mix**); when KplFad = 0, FadDiv and DeiOfs are don't cares |
| **Proscan6** | 0F0 | write; S | | | | | | | | | |
| EddiOut | | | | | | | | | | X | turns EDDI on and off (**off or on**) |
| EddiDemo | | | | | | | | | X | | activates split screen demonstration mode for EDDI (**off or on**) |
| EddiCmp | | | | | | | X | X | | | Factor to specify the size of the additional compensation area left and right of the 'real' edge. A high factor (e.g. 1) can increase the compensation in regions far away from the true edge (**1, $\frac{1}{2}$, $\frac{1}{4}$ or $\frac{1}{8}$**). |

| NAME | SNERT ADDRESS (HEX) | READ/ WRITE[1] | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 | DESCRIPTION[2] |
|---|---|---|---|---|---|---|---|---|---|---|---|---|
| **Proscan7** | 0F1 | write; S | | | | | | | | | |
| EddiMR | | | | | | | | | X | X | Factor for the comparison of the monotonous regions belonging to two edge points to verify an edge (**1, ½, ¼ or ⅛**). |
| EddiED | | | | | | | X | X | | | Factor for the comparison of the monotonous regions belonging to two edge points and the edge point distance to verify an edge (**1, ½, ¼ or ⅛**). |
| EddiDif | | | X | X | X | X | | | | | minimal required Y difference at edge point position to be a reliable edge point; higher values result in higher reliability of EDDI, but less edges will be detected (**0 to 60 in multiples of 4**) |
| **Proscan8** | 0F2 | write; S | | | | | | | | | |
| EddiFil | | | | | | | X | X | X | X | minimal required edge filter value at start and end of the monotonous region to be a reliable edge point; should be set higher in pictures with noise (**0 to 60 in multiples of 4**) |
| EddiLng | | | | | X | X | | | | | minimal required length of monotonous region to be reliable; higher values result in higher reliability of EDDI, but less steep edges will be detected (**2, 3, 4 or 5**) |
| **Proscan9** | 0F3 | write; S | | | | | | | | | |
| EddiOfs | | | | | | | X | X | X | X | offset to increase or decrease the amount of EDDI compensation; lower values increase the amount of compensation (**1 to 16**) |
| EddiLim | | | X | X | X | X | | | | | limitation of the compensation factor of EDDI; 1 limits to full EDDI compensation, 16 limits to almost no EDDI compensation (**1 to 16**) |
| **General** | | | | | | | | | | | |
| **NrBlks** | 020 | write; S | | | | | | | | | |
| NrBlks | | | | | X | X | X | X | X | X | number of blocks in active video (**6 to 53**, corresponds to 96 to 848 pixels), to be set as $\frac{1}{16}$ (number of active pixels per line + 15); take remarks on TotalPxDiv8 into consideration |
| TotalLnsAct98 | | | X | X | | | | | | | total number of output lines (bits 9 and 8) |
| **TotalLnsAct70** | 021 | write; S | X | X | X | X | X | X | X | X | total number of output lines (bits 7 to 0) |

Field and line rate converter with noise reduction and embedded memory

| NAME | SNERT ADDRESS (HEX) | READ/ WRITE[1] | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 | DESCRIPTION[2] |
|---|---|---|---|---|---|---|---|---|---|---|---|
| **TotalPxDiv8** | 022 | write; S | X | X | X | X | X | X | X | X | Total number of pixels per line divided-by-8 (**80 to 128**, corresponds to 640 to 1 024 pixels). The horizontal blanking interval is calculated as TotalPxDiv8 − 2 × NrBlks and has to be in the range from 12 to 124 (corresponds to 96 to 992 pixels). Conclusion: TotalPxDiv8 has to be set to 12 + 2 × NrBlks < TotalPxDiv8 < 124 + 2 × NrBlks and NrBlks has to be set to $\dfrac{\text{TotalPxDiv8} - 124}{2} < \text{NrBlks} < \dfrac{\text{TotalPxDiv8} - 12}{2}$ |
| **REaShift** | 023 | write; S | | | | | | X | X | X | shift of REA signal in number of pixels (**0, +1, +2, +3,** −4, −3, −2 **or** −1) |
| **WEbdREceShift** | 024 | write; S | | | | | | | | | |
| WEbdShift | | | | | | | | X | X | X | reserved |
| REceShift | | | | X | X | X | | | | | reserved |
| **POR** | 025 | write; S | | | | | | | | X | power-on reset command, to be set high temporarily during start-up (**normal or reset**); note 3 |
| **ScalingFactor** | 0D6 | write; S | X | X | X | X | X | X | X | X | 8-bit scaling factor for EggSliceMix, EggSliceRgt and global activity (the same factor for all registers). output value (n+1) $= \dfrac{\text{ScalingFactor}}{128} \times$ output value (n) |
| **FieldMemoryControl** | 000 | write; F | | | | | | | | | |
| PIPON | | | | | | | | | | X | Picture-In-Picture (PIP) field memory mode enable |
| TWOFMON | | | | | | | | | 0 | | has to be set to logic 0 |
| PIPDataDelay | | | | | | | | X | | | input data will be delayed by one clock cycle with respect to WE2 (write enable) |
| PIPStillPicture | | | | | | | X | | | | no new data will be written into the field memory |

| NAME | SNERT ADDRESS (HEX) | READ/ WRITE[1] | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 | DESCRIPTION[2] |
|---|---|---|---|---|---|---|---|---|---|---|---|
| **Mode control** | | | | | | | | | | | |
| **Control1** | 026 | write; F | | | | | | | | | |
| EstMode | | | | | | | | | | X | Set estimator mode; **0** = line alternating use of left and right estimator: use in progressive scan except with vertical compress. **1** = field alternating use of left and right estimator: use in field doubling and progressive scan with vertical compress. |
| FilmMode | | | | | | | | | X | | set film mode; **0** = video camera mode; **1** = film mode |
| UpcMode | | | | | | | X | X | | | select upconversion quality; **00** = full, **01** = economy (DPCM), **10** = single memory with motion compensation, **11** = single memory without motion compensation |
| MatrixOn | | | | | | X | | | | | set matrix output mode; **1** = double output, disabling vertical peaking; **0** = normal single output mode; this bit setting is the AND function of BusGControl bits |
| EmbraceOn | | | | | X | | | | | | Master enable for embrace mode (**off or on**); SwapMpr in control2 should be at 'swap' position to really cross-switch FM1 and FM3 field outputs. Should be set to logic 0 except in film mode and FM3 is present. |
| MemComp | | | | X | | | | | | | set memory compression (luminance DPCM) (**off or on**) |
| MemDecom | | | X | | | | | | | | set memory decompression (luminance DPCM) (**off or on**) |

| NAME | SNERT ADDRESS (HEX) | READ/ WRITE[1] | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 | DESCRIPTION[2] |
|---|---|---|---|---|---|---|---|---|---|---|---|
| **Control2** | 027 | write; F | | | | | | | | | |
| QQcurr | | | | | | | | | | X | Quincunx phase of current field (in TPM) (**phase0 or phase1**); this needs to toggle each time a new field comes from FM1. In phase0 the estimator operates on a checker-board pattern that starts with the left upper block; in phase1 the other blocks are estimated. |
| QQprev | | | | | | | | | X | | Quincunx phase of previous field (in TPM) (**phase0 or phase1**); this is the value of QQcurr during the last estimate written into the temporal prediction memory |
| FldStat | | | | | | | | X | | | Field status (**same input field or new input field**); reflects whether the output of FM1 is a new or a repeated field. This bit will toggle field by field in field doubling mode and is continuously HIGH in progressive output mode. |
| FieldWeYUV | | | | | | | X | | | | enable writing FM2 and FM3 for both luminance and chrominance (recirculation of data for luminance alone can be controlled with OrigFmEnY and IntpFmEnY in Control3) (**off or on**) |
| OddFM1 | | | | | | X | | | | | odd input field (**even or odd**), this is to be set equal to the detected field interlace for the field that comes out of FM1 |
| SwapMpr | | | | | X | | | | | | Swap multi port RAMs (**normal or swap**); this bit needs to be set to get real frame data at the temporal position from FM1. If swapped, the current field (FM1) will be stored in the right line memory tree, while the original lines from the stored frame (FM2/3) are stored in the left memory tree. Should be set only in film mode if FM3 is present; EmbraceOn must be set as well. |
| VecOffs | | | X | X | | | | | | | Set vertical vector offset (**0, +1, − or −1**) frame lines; vertical offset of the right line memory tree with respect to the left line memory tree. A higher offset value means: on the right memory tree access to less delayed video lines is taken; in interlaced video operation, the vertical offset will be −1 with an odd field on the left side and +1 with an even field on the left. With non-interlaced input, vertical offset should be constantly 0. In film mode, vertical offset is dynamically switched between +1, 0 and −1. |

Field and line rate converter with noise reduction and embedded memory

| NAME | SNERT ADDRESS (HEX) | READ/WRITE[1] | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 | DESCRIPTION[2] |
|---|---|---|---|---|---|---|---|---|---|---|---|
| **Control3** | 028 | write | | | | | | | | | |
| OddLeft | | F | | | | | | | | X | interlace (**even or odd**) phase of the field which is written to the left line memory tree (left MPRAM) |
| OrigFmEnY | | | | | | | | X | | | enables writing luminance from de-interlacer in original field memory (FM2), otherwise recirculation of luminance that is just read from FM2 (**recirculate or update**) |
| IntpFmEnY | | | | | | | X | | | | enables writing luminance from de-interlacer in interpolated field memory (FM3), otherwise recirculation of luminance that is just read from FM3 (**recirculate or update**) |
| FillTPM | | | | | | X | | | | | Enables writing in temporal prediction memory (**keep or update**); FillTPM should be set to 'keep' in single memory film mode, in those output fields where FM1 and FM2 contain the same motion phase. FillTPM should be set to 'update' in all other situations. |
| VertOffsDNR | | | | | X | X | | | | | Set vertical vector offset of DNR (**0, +1, −** or **−1**) frame lines; vertical offset of the right line memory tree with respect to the left line memory tree, before the swap action. A higher offset value means: on the right memory tree access to less delayed video lines is taken; in interlaced video operation, the vertical offset will be −1 with an odd field on the left side and +1 with an even field on the left. With non-interlaced input, vertical offset should be constantly logic 0; in film mode, vertical offset is dynamically switched between +1, 0 and −1. It should be noted that the signal OddFM1 is used to determine this offset. |
| BusGControl | | S | X | X | | | | | | | Select output mode of bus G; **00** = normal single output mode (bus G in 3-state), **01** = output of motion vectors to UVG (motion_x on U and motion_y on V), **10** = copy bus F to G, **11** = double output, disabling vertical peaking. Only when double output is selected, the MatrixOn bit in register Control1 should be set, otherwise it needs to be cleared. |
| **Upconversion** | | | | | | | | | | | |
| **Upconv1** | 029 | write; F | | | | | | | | | |
| UpcShFac | | | | | X | X | X | X | X | X | temporal interpolation factor used in luminance upconverter; value ranges from **0** (for current field position) **to 32** (for previous field position) |

| NAME | SNERT ADDRESS (HEX) | READ/ WRITE[1] | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 | DESCRIPTION[2] |
|---|---|---|---|---|---|---|---|---|---|---|---|
| **Upconv2** | 02A | write | | | | | | | | | |
| YVecClip | | S | | | | | | X | X | X | value used for coring the vertical vector component before application in the upconverter; range: **0 to 3.5** in steps of 0.5 line; should remain at logic 0 in normal operation |
| RollBack | | F | X | X | X | X | X | | | | roll back factor ranging from **0** (use 0% of estimated vectors) **to 16** (use 100% of estimated vectors) |
| **Upconv3** | 02B | write; S | | | | | | | | | |
| MelzLfbm | | | | | | | | | | X | single memory type local fallback method instead of more robust local fallback (**double memory or single memory type fallback**) |
| Melzmemc | | | | | | | | X | | | single memory film mode control (**double memory or single memory type**); should be set in single memory film mode to ensure that only original lines are selected as output when UpcShFac is 0 or 32 |
| MelDeint | | | | | | | X | | | | use horizontal motion compensated median for upconverter de-interlacing (**full FALCONIC or single memory type de-interlacing**) |
| MixCtrl | | | X | X | X | X | X | | | | Bits 3 and 4 are used to control sensitivity to local vector smoothness (**0** = sensitive to unsmoothness, **3** = hardly sensitive to unsmoothness). Bits 5 to 7 define the maximum contribution of non-motion compensated pixels to the output (**0, $\frac{1}{8}$, $\frac{2}{8}$, $\frac{3}{8}$, $\frac{4}{8}$, $\frac{5}{8}$, $\frac{6}{8}$ or $\frac{7}{8}$**). |
| **UpcColShiFac** | 0C4 | write; F | | | X | X | X | X | X | X | temporal interpolation factor used in chrominance upconverter; value ranges from **0** (for current field position) **to 32** (for previous field position) |
| **Upconv4** | 0C5 | write; S | | | | | | | | | |
| LfIndex | | | | | | | | X | X | X | Number of consecutive lines to have bad egg-slice values before upconverter goes into protection mode (**0, 1, 2, 4, 8, 16, 32 or 64**). A value of 0 switches off the possibility to go into protection. |
| MCDemo | | | X | | | | | | | | mode switch on left side of the screen; **0** (natural motion); **1** (digital scan-like processing) |
| **EggSlice1** | 0C6 | write; S | | | | | | | | | |
| EggStartLine | | | X | X | X | X | X | X | X | X | Reference line number at which the egg slice measurement should start. SAA4998H defines a window internally as number of lines between EggStartLine and (MaxRefLine − EggStartLine). |

| NAME | SNERT ADDRESS (HEX) | READ/ WRITE[1] | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 | DESCRIPTION[2] |
|---|---|---|---|---|---|---|---|---|---|---|---|
| **EggSlice2** | 0C7 | write; S | | | | | | | | | |
| EggSlcThr | | | | | X | X | X | X | X | X | Minimum line egg slice right value to activate reliability measurement. The parameter is multiplied internally by 4. |
| EggRelInd | | | X | X | | | | | | | The egg slice reliability is computed internally as EggSliceRgt (ESR) > RelFactor $\times$ EggSliceMix (ESM). RelFactor is determined by EggRelInd ($\frac{2}{8}$, $\frac{3}{8}$, $\frac{4}{8}$ or $\frac{6}{8}$). |
| **SafeShiFac** | 0C8 | write; F | | | X | X | X | X | X | X | upconverter shift factor to be used in protection mode; **0** (for current field position) **to 32** (for previous field position) |
| **Motion estimator** | | | | | | | | | | | |
| **Motest1** | 02C | write; S | | | | | | | | | |
| PenOdd | | | | | | | | X | X | X | additional penalty on vector candidates with odd vertical component (**0, 8, 16, 32, 64, 128, 256 or 511**) |
| SpcThr | | | | | X | X | X | | | | Active when EstMode = 0; replace the spatial prediction of one estimator (left or right) by that of the other if the match error of the former exceeds that of the latter by more than (**0, 8, 16, 32, 64, 128, 256 or 511**). A higher threshold means the two estimators are very independent. |
| BmsThr | | | X | X | | | | | | | Active when EstMode = 0; select as estimated vector the output of the right estimator unless its match error exceeds that of the left estimator by more than (**0, 8, 16 or 32**). This parameter should normally be set to logic 0. |
| **Motest2** | 02D | write; S | | | | | | | | | |
| TavLow | | | | | | | | | | X | If the difference between the current vector and the previous one in the same spatial location is within a small window, then the two vectors are averaged to improve temporal consistency. TavLow is the lower threshold of this window (**1 or 2**). |
| TavUpp | | | | | | | | X | X | | see above; TavUpp is the upper threshold (**0, 4, 8 or 16**) |
| MedEns | | | | | | X | X | | | | scaling factor to reduce all sizes of update vectors in the ensemble with medium sized vector templates (**1, $\frac{1}{2}$, $\frac{1}{4}$ or $\frac{1}{8}$**) |
| LarEns | | | | X | X | | | | | | scaling factor to reduce all sizes of update vectors in the ensemble with large sized vector templates (**1, $\frac{1}{2}$, $\frac{1}{4}$ or $\frac{1}{8}$**) |

| NAME | SNERT ADDRESS (HEX) | READ/ WRITE[1] | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 | DESCRIPTION[2] |
|---|---|---|---|---|---|---|---|---|---|---|---|
| **Motest3** | 02E | write; F | | | | | | | | | |
| MotShiFac | | | | | X | X | X | X | X | X | Motion estimator shift factor, being the temporal position used in the estimator at which the matching is done; value **32** for matching at previous field position down **to 0** for matching at current field position. Keeping MotShiFac equal to UpShiFac in the next upconverted output field estimates for minimum matching errors (minimum Halo's). MotShiFac at value **16** gives the largest natural vector range (twice as large as with value 0 or 32). Going above the range with MotShiFac $\neq$ 16 is dealt with in SAA4998H by shifting towards 16, but for the horizontal and vertical component separately (consequence is that vector candidates tend to rotate towards the diagonal directions). |
| **Motest4** | 02F | write; S | | | | | | | | | |
| PenRng | | | | | | | | | | X | Penalty for vectors estimated on the first row and the first column (if left estimator is used) or the right column (if right estimator is used), whenever the spatial prediction candidate is selected (**64 or 511**). For noisy pictures, this register could be set to logic 1 to improve border processing in the estimator. |
| CndSet | | | | | | | | X | | | choice of candidate set (**left or right**) for which data (Candidate1 to Candidate8) is written in this field (becomes active in next field); note 3 |
| ErrThr | | | | | | X | X | X | | | threshold on block match error for considering a block to be bad (**16, 32, 64, 128, 256, 512, 1024 or 2032**) |
| ErrHbl | | | | X | X | | | | | | number of horizontally adjacent blocks that have to be all bad before considering an occurrence of a burst error (**1, 2, 4 or 8**) (counting of burst errors is read out with BlockErrCnt, address 0A8H) |
| TstMod | | | X | | | | | | | | to be kept to logic 1 for normal operation |
| **Motest5** | 0CC | write; S | | | | | | | | | |
| ActOption | | | | | | | | | X | X | selection of the vector component to take in the activity count ($|$**x**$|$ **+** $|$**y**$|$, $|$**x**$|$, $|$**y**$|$ or −) |
| ClearTPM | | | X | | | | | | | | write zeros in the temporal prediction memory (**no writing or writing zeros**) |
| **LoActThr** | 0CD | write; S | X | X | X | X | X | X | X | X | blocks having an activity value below or equal to this threshold are counted as having LOW activity |
| **HiActThr** | 0CE | write; S | X | X | X | X | X | X | X | X | blocks having an activity value above this threshold are counted as having HIGH activity |

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| NAME | SNERT ADDRESS (HEX) | READ/ WRITE[1] | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 | DESCRIPTION[2] |
|---|---|---|---|---|---|---|---|---|---|---|---|
| **LeftBorder** | 0CF | write; S | | | | | | | | | |
| LeftBorder | | | | X | X | X | X | X | X | X | estimator left border (in 8-pixel blocks) |
| WinNullWrite | | | X | | | | | | | | enable writing of null vectors outside estimators' active window (**off or on**) |
| **RightBorder** | 0D0 | write; S | | X | X | X | X | X | X | X | estimator right border (in 8-pixel blocks) |
| **TopBorder** | 0D1 | write; S | | X | X | X | X | X | X | X | estimator top border (in 4-line blocks) |
| **BottomBorder** | 0D2 | write; S | | X | X | X | X | X | X | X | estimator bottom border (in 4-line blocks) |
| **Candidate1** | 090 | write; S | | | | | | | | | |
| Candidat1 | | | | | | | | X | X | X | selection Candidate1 (**SpatLeft, SpatRight, TemporalRight, TemporalLeft, TemporalCentre, Null, Panzoom or Max**) |
| Update1 | | | | | | X | X | | | | update for Candidate1 (**zero update, medium update, large update or zero update**) |
| Penalty1 | | | X | X | X | | | | | | penalty for Candidate1 (**0, 8, 16, 32, 64, 128, 256 or 511**) |
| **Candidate2** | 091 | write; S | | | | | | | | | |
| Candidat2 | | | | | | | | X | X | X | selection Candidate2 (**SpatLeft, SpatRight, TemporalRight, TemporalLeft, TemporalCentre, Null, Panzoom or Max**) |
| Update2 | | | | | | X | X | | | | update for Candidate2 (**zero update, medium update, large update or zero update**) |
| Penalty2 | | | X | X | X | | | | | | penalty for Candidate2 (**0, 8, 16, 32, 64, 128, 256 or 511**) |
| **Candidate3** | 092 | write; S | | | | | | | | | |
| Candidat3 | | | | | | | | X | X | X | selection Candidate3 (**SpatLeft, SpatRight, TemporalRight, TemporalLeft, TemporalCentre, Null, Panzoom or Max**) |
| Update3 | | | | | | X | X | | | | update for Candidate3 (**zero update, medium update, large update or zero update**) |
| Penalty3 | | | X | X | X | | | | | | penalty for Candidate3 (**0, 8, 16, 32, 64, 128, 256 or 511**) |
| **Candidate4** | 093 | write; S | | | | | | | | | |
| Candidat4 | | | | | | | | X | X | X | selection Candidate4 (**SpatLeft, SpatRight, TemporalRight, TemporalLeft, TemporalCentre, Null, Panzoom or Max**) |
| Update4 | | | | | | X | X | | | | update for Candidate4 (**zero update, medium update, large update or zero update**) |
| Penalty4 | | | X | X | X | | | | | | penalty for Candidate4 (**0, 8, 16, 32, 64, 128, 256 or 511**) |

| NAME | SNERT ADDRESS (HEX) | READ/ WRITE[1] | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 | DESCRIPTION[2] |
|---|---|---|---|---|---|---|---|---|---|---|---|
| **Candidate5** | 094 | write; S | | | | | | | | | |
| Candidat5 | | | | | | | | X | X | X | selection Candidate5 (**SpatLeft, SpatRight, TemporalRight, TemporalLeft, TemporalCentre, Null, Panzoom or Max**) |
| Update5 | | | | | | X | X | | | | update for Candidate5 (**zero update, medium update, large update or zero update**) |
| Penalty5 | | | X | X | X | | | | | | penalty for Candidate5 (**0, 8, 16, 32, 64, 128, 256 or 511**) |
| **Candidate6** | 095 | write; S | | | | | | | | | |
| Candidat6 | | | | | | | | X | X | X | selection Candidate6 (**SpatLeft, SpatRight, TemporalRight, TemporalLeft, TemporalCentre, Null, Panzoom or Max**) |
| Update6 | | | | | | X | X | | | | update for Candidate6 (**zero update, medium update, large update or zero update**) |
| Penalty6 | | | X | X | X | | | | | | penalty for Candidate6 (**0, 8, 16, 32, 64, 128, 256 or 511**) |
| **Candidate7** | 096 | write; S | | | | | | | | | |
| Candidat7 | | | | | | | | X | X | X | selection Candidate7 (**SpatLeft, SpatRight, TemporalRight, TemporalLeft, TemporalCentre, Null, Panzoom or Max**) |
| Update7 | | | | | | X | X | | | | update for Candidate7 (**zero update, medium update, large update or zero update**) |
| Penalty7 | | | X | X | X | | | | | | penalty for Candidate7 (**0, 8, 16, 32, 64, 128, 256 or 511**) |
| **Candidate8** | 097 | write; S | | | | | | | | | |
| Candidat8 | | | | | | | | X | X | X | selection Candidate8 (**SpatLeft, SpatRight, TemporalRight, TemporalLeft, TemporalCentre, Null, Panzoom or Max**) |
| Update8 | | | | | | X | X | | | | update for Candidate8 (**zero update, medium update, large update or zero update**) |
| Penalty8 | | | X | X | X | | | | | | penalty for Candidate8 (**0, 8, 16, 32, 64, 128, 256 or 511**) |
| **PZpositionLeftUppX** | 098 | write; S | | | X | X | X | X | X | X | X position of LeftUpp measurement point for pan-zoom calculations (resolution: 16 pixels) |
| **PZpositionLeftUppY** | 099 | write; S | | X | X | X | X | X | X | X | Y position of LeftUpp measurement point for pan-zoom calculations (resolution: 4 lines) |
| **PZpositionRightLowX** | 09A | write; S | | | X | X | X | X | X | X | X | X position of RightLow measurement point for pan-zoom calculations (resolution: 16 pixels) |
| **PZpositionRightLowY** | 09B | write; S | | X | X | X | X | X | X | X | Y position of RightLow measurement point for pan-zoom calculations (resolution: 4 lines) |
| **PZvectorStartX** | 09C | write; F | X | X | X | X | X | X | X | X | X start value of pan-zoom vectors |

Philips Semiconductors

Field and line rate converter with noise
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SAA4998H

Product specification

| NAME | SNERT ADDRESS (HEX) | READ/ WRITE[1] | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 | DESCRIPTION[2] |
|---|---|---|---|---|---|---|---|---|---|---|
| **PZvectorDeltaX** | 09D | write; F | X | X | X | X | X | X | X | X | X delta value of pan-zoom vectors |
| **PZvectorStartY** | 09E | write; F | X | X | X | X | X | X | X | X | Y start value of pan-zoom vectors |
| **PZvectorDeltaY** | 09F | write; F | X | X | X | X | X | X | X | X | Y delta value of pan-zoom vectors |
| **Read data;** note 3 | | | | | | | | | | | |
| **GlobalMSEmsb** | 0A0 | read; F | X | X | X | X | X | X | X | X | Global Mean Square Error (MSE) = summation within a field period of squared differences in comparing vector shifted video from frame memory (FM2/3) with new field input (FM1) in those lines coinciding with new field lines. The window for the measurement is kept at 40 pixels horizontal and 20 field lines vertical from the border of the video. Measurements is only done in fields where the de-interlacer is active, otherwise reading is zero. In field doubling mode, MSE is zero at the end of every new input field. |
| **GlobalMSElsb** | 0A1 | read; F | X | X | X | X | X | X | X | X | |
| **GlobalMTImsb** | 0A2 | read; F | X | X | X | X | X | X | X | X | Global Motion Trajectory Inconsistency (MTI) = summation within a field period of squared differences comparing shifted video from frame memory (FM2/3 output) with filtered data that is rewritten to the frame memory (FM2/3 input) in those lines coinciding with new field lines. The window for the measurement is kept at 40 pixels horizontal and 20 field lines vertical from the border of the video. Measurement is done only in fields where de-interlacer is active, otherwise reading is zero; in field doubling mode, MTI is zero at the end of every new input field. |
| **GlobalMTIlsb** | 0A3 | read; F | X | X | X | X | X | X | X | X | |
| **GlobalACTmsb** | 0A4 | read; F | X | X | X | X | X | X | X | X | global activity (ACT) = summation over a field period of the horizontal plus the vertical components of the vectors of all blocks |
| **GlobalACTlsb** | 0A5 | read; F | X | X | X | X | X | X | X | X | |
| **VectTempCons** | 0A6 | read; F | X | X | X | X | X | X | X | X | Vector temporal consistency = summation over a field period of absolute differences of horizontal plus vertical components of vectors newly estimated for each block compared with those vectors estimated in the previous run at the same spatial block position. It should be noted that a lower figure implies better consistency. |
| **VectSpatCons** | 0A7 | read; F | X | X | X | X | X | X | X | X | Vector spatial consistency = summation over a field period of absolute differences of horizontal and vertical components of vectors compared with those of the neighbour blocks (L, R, U and D); in the comparison, all vector data is used from the previous estimator run. It should be noted that a lower figure implies better consistency. |
| **BlockErrCnt** | 0A8 | read; F | X | X | X | X | X | X | X | X | burst error count (number of burst errors) |

| NAME | SNERT ADDRESS (HEX) | READ/ WRITE[1] | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 | DESCRIPTION[2] |
|---|---|---|---|---|---|---|---|---|---|---|---|
| **LeastErrSum** | 0A9 | read; F | X | X | X | X | X | X | X | X | least error sum (summation over a field period of the smallest match error that the estimator has found for each block: indicates reliability of the estimation process) |
| **YvecRangeErrCntmsb** | 0AA | read; F | X | X | X | X | X | X | X | X | Y vector range error count (number of vectors that have a vertical component that is out of range for upconversion at the chosen temporal position) (15 to 8) |
| **YvecRangeErrCntlsb** | 0AB | read; F | X | X | X | X | X | X | X | X | Y vector range error count (7 to 0) |
| **RefLineCountPrev** | 0AC | read; F | X | X | X | X | X | X | X | X | read out of [number of input (run-) lines − 40] used in previous field |
| **RefLineCountNew** | 0AD | write; F | X | X | X | X | X | X | X | X | Write of [number of input (run-) lines − 40] to be used in new field (actual maximum number of input lines in normal operation: 292; register value 252). Nominally this is to be set as an exact copy of the value read from RefLineCountPrev before a new field starts. In case the effective number of input (run-) lines has increased, RefLineCountNew should, for one field, be set to 255. This will occur e.g. with decreasing vertical zoom magnification or changing from 525 lines video standard to 625 lines standard. If this is not done, a deadlock will occur with too few lines processed correctly by the motion estimator. |
| **PanZoomVec0-X** | 0B0 | read; F | X | X | X | X | X | X | X | X | pan-zoom vector 0 (8-bit X value) |
| **PanZoomVec0-Y** | 0B1 | read | | | | | | | | | |
| FalconIdent | | S | 0 | | | | | | | | SAA4998H identification: fixed bit, reading this bit as zero means SAA4998H is present |
| PanZoomVec0-Y | | F | | X | X | X | X | X | X | X | pan-zoom vector 0 (7-bit Y value) |
| **PanZoomVec1-X** | 0B2 | read; F | X | X | X | X | X | X | X | X | pan-zoom vector 1 (8-bit X value) |
| **PanZoomVec1-Y** | 0B3 | read | | | | | | | | | |
| StatusJump0 | | S | X | | | | | | | | **1**: both field memories are in use by the motion estimation and motion compensation function; see Fig.1<br>**0**: field memory 2 is in use by the motion estimation and motion compensation function; field memory 3 for PIP application; see Fig.1 |
| PanZoomVec1-Y | | F | | X | X | X | X | X | X | X | pan-zoom vector 1 (7-bit Y value) |
| **PanZoomVec2-X** | 0B4 | read; F | X | X | X | X | X | X | X | X | pan-zoom vector 2 (8-bit X value) |
| **PanZoomVec2-Y** | 0B5 | read | | | | | | | | | |
| StatusJump1 | | S | 1 | | | | | | | | logic 1 |
| PanZoomVec2-Y | | F | | X | X | X | X | X | X | X | pan-zoom vector 2 (7-bit Y value) |

Field and line rate converter with noise
reduction and embedded memory

Product specification

SAA4998H

| NAME | SNERT ADDRESS (HEX) | READ/ WRITE[1] | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 | DESCRIPTION[2] |
|---|---|---|---|---|---|---|---|---|---|---|---|
| **PanZoomVec3-X** | 0B6 | read; F | X | X | X | X | X | X | X | X | pan-zoom vector 2 (8-bit X value) |
| **PanZoomVec3-Y** | 0B7 | read; F | | X | X | X | X | X | X | X | pan-zoom vector 3 (7-bit Y value) |
| **PanZoomVec4-X** | 0B8 | read; F | X | X | X | X | X | X | X | X | pan-zoom vector 4 (8-bit X value) |
| **PanZoomVec4-Y** | 0B9 | read; F | | X | X | X | X | X | X | X | pan-zoom vector 4 (7-bit Y value) |
| **PanZoomVec5-X** | 0BA | read; F | X | X | X | X | X | X | X | X | pan-zoom vector 5 (8-bit X value) |
| **PanZoomVec5-Y** | 0BB | read; F | | X | X | X | X | X | X | X | pan-zoom vector 5 (7-bit Y value) |
| **PanZoomVec6-X** | 0BC | read; F | X | X | X | X | X | X | X | X | pan-zoom vector 6 (8-bit X value) |
| **PanZoomVec6-Y** | 0BD | read; F | | X | X | X | X | X | X | X | pan-zoom vector 6 (7-bit Y value) |
| **PanZoomVec7-X** | 0BE | read; F | X | X | X | X | X | X | X | X | pan-zoom vector 7 (8-bit X value) |
| **PanZoomVec7-Y** | 0BF | read; F | | X | X | X | X | X | X | X | pan-zoom vector 7 (7-bit Y value) |
| **PanZoomVec8-X** | 0AE | read; F | X | X | X | X | X | X | X | X | pan-zoom vector 8 (8-bit X value) |
| **PanZoomVec8-Y** | 0AF | read; F | | X | X | X | X | X | X | X | pan-zoom vector 8 (7-bit Y value) |
| **EggSliceRgtMSB** | 0C0 | read; F | X | X | X | X | X | X | X | X | result of right pixels egg-slice detector (15 to 8) |
| **EggSliceRgtLSB** | 0C1 | read; F | X | X | X | X | X | X | X | X | result of right pixels egg-slice detector (7 to 0) |
| **EggSliceMixMSB** | 0C2 | read; F | X | X | X | X | X | X | X | X | result of mixed pixels egg-slice detector (15 to 8) |
| **EggSliceMixLSB** | 0C3 | read; F | X | X | X | X | X | X | X | X | result of mixed pixels egg-slice detector (7 to 0) |
| **SafeFbLine** | 0C9 | read; F | X | X | X | X | X | X | X | X | reference line number (divided by two) at which the upconverter goes into protection mode |
| **EggBinGoodness** | 0CA | read; F | X | X | X | X | X | X | X | X | Goodness of the four egg-slice sections, from top to bottom, 2 bits per section. Each section is represented with 2 bits in this register, where bits 0 and 1 represent the top section and bits 6 and 7 represent the lowest of the 4 sections. Each pair of bits indicate **00** = (ESR > $\frac{3}{4}$ESM), **01** = ($\frac{1}{2}$ESM < ESR ≤ $\frac{3}{4}$ESM), **10** = ($\frac{1}{4}$ESM < ESR ≤ $\frac{1}{2}$ESM), **11** = (ESR ≤ $\frac{1}{4}$ESM). |
| **LoActCnt** | 0D3 | read; F | X | X | X | X | X | X | X | X | number of blocks having low activity |
| **HiActCnt** | 0D4 | read; F | X | X | X | X | X | X | X | X | number of blocks having high activity |
| **NullErrSum** | 0D5 | read; F | X | X | X | X | X | X | X | X | sum of errors for the null candidate over the complete field; when no null candidate is selected a value of FFH will be read |

**Notes**

1. S means semi static, used at initialization or mode changes; F means field frequent, in general updated in each display field.

2. Selectable items are marked bold.

3. Almost all of the R(ead) and W(rite) registers of SAA4998H are double buffered. The write registers are latched by a signal called New_field. New_field gets set, when REF rises after SNRST (New_field is effectively at the start of active video). The read registers are latched by a signal called Reg_upd. Reg_upd gets set, when half the number of active pixels of the fourth line of vertical blanking have entered the SAA4998H (Reg_upd will effectively be active $3\frac{1}{2}$ lines after the REA has ended). The only exception are the registers which are not double buffered, these are as follows:

   a) Write register 025H: power_on_reset

   b) Write register 02FH, bit 1: CndSet

   c) Read register 0B0H to 0BFH, 0AEH and 0AFH: pan_zoom_vectors, including FalconIdent (= 0), StatusJump0 and StatusJump1.

## 8 LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|--------|-----------|------------|------|------|------|
| $V_{DDD}$ | core supply voltage (internal rail) | | −0.5 | +2.5 | V |
| $V_{DDA}$ | analog supply voltage | | | | |
| $V_{DDM}$ | field memory supply voltage | | | | |
| $V_{DDS}$ | SRAM supply voltage | | | | |
| $V_{DDE}$ | external supply voltage (output pads) | | −0.5 | +4.6 | V |
| $V_{DDP}$ | high supply voltage of internal field memories | | | | |
| $V_i$ | input voltage of all I/O pins | | −0.5 | +6[1] | V |
| $I_o$ | output current | | − | 4 | mA |
| $T_{stg}$ | storage temperature | | −40 | +125 | °C |
| $T_j$ | junction temperature | | 0 | 125 | °C |
| $V_{esd}$ | electrostatic discharge voltage on all pins | MM; note 2 | −400 | +400 | V |
| | | HBM; note 3 | −3000 | +3000 | V |

**Notes**

1. Only valid, if $V_{DDE}$ is present.

2. In accordance with *"Transient energy (ESD machine model); SNW-FQ-302B"* class C, discharging a 200 pF capacitor via a 0.75 µH series inductance.

3. In accordance with *"Transient energy (ESD human body model); SNW-FQ-302A"* class 2, discharging a 100 pF capacitor via a 1.5 kΩ series resistor.

## 9 THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|--------|-----------|------------|-------|------|
| $R_{th(j-a)}$ | thermal resistance from junction to ambient | in free air | 45 | K/W |
| $R_{th(j-c)}$ | thermal resistance from junction to case | | 10 | K/W |

## 10 CHARACTERISTICS

$V_{DDE}$ = 3.0 to 3.6 V; $T_{amb}$ = 0 to 70 °C; unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---|---|---|---|---|---|---|
| **Supplies** | | | | | | |
| $V_{DDD}$ | core supply voltage (internal rail) | | 1.65 | 1.8 | 1.95 | V |
| $V_{DDA}$ | analog supply voltage | | | | | |
| $V_{DDM}$ | field memory supply voltage | | | | | |
| $V_{DDS}$ | SRAM supply voltage | | | | | |
| $V_{DDE}$ | external supply voltage (output pads) | | 3.0 | 3.3 | 3.6 | V |
| $V_{DDP}$ | high supply voltage of internal field memories | | | | | |
| $I_{DD}$ | sum of supply current | | | | | |
| | at 1.8 V supply voltage pins | | – | 180 | – | mA |
| | at 3.3 V supply voltage pins | | – | 6 | – | mA |
| **General** | | | | | | |
| $V_{OH}$ | HIGH-level output voltage | | $V_{DDE}$ − 0.4 | – | – | V |
| $V_{OL}$ | LOW-level output voltage | | – | – | 0.4 | V |
| $V_{IH}$ | HIGH-level input voltage | | 2 | – | – | V |
| $V_{IL}$ | LOW-level input voltage | | – | – | 0.8 | V |
| $I_{OH}$ | HIGH-level output current | 10 ns slew rate output; $V_{OH} = V_{DDE}$ − 0.4 V | −4 | – | – | mA |
| $I_{OL}$ | LOW-level output current | 10 ns slew rate output; $V_{OL}$ = 0.4 V | – | – | 4 | mA |
| $C_i$ | input capacitance | | – | – | 8 | pF |
| $I_{LI}$ | input leakage current | note 1 | – | – | 1 | μA |
| **Outputs;** see Fig.5; note 2 | | | | | | |
| $I_{OZ}$ | output current in 3-state mode | $−0.5 < V_o < 3.6$ | – | – | 1 | μA |
| $t_{d(o)}$ | output delay time | | – | – | 23 | ns |
| $t_{h(o)}$ | output hold time | | 4 | – | – | ns |
| **Inputs** | | | | | | |
| $t_r$ | rise time | | – | – | 30 | ns |
| $t_f$ | fall time | | – | – | 30 | ns |
| $t_{su(i)}$ | input set-up time | see Fig.5; note 3 | 6 | – | – | ns |
| $t_{h(i)}$ | input hold time | see Fig.5; note 3 | 2 | – | – | ns |
| **Input CLK32;** see Fig.5 | | | | | | |
| $t_r$ | rise time | | – | – | 4 | ns |
| $t_f$ | fall time | | – | – | 4 | ns |
| $\delta$ | duty factor | | 40 | – | 60 | % |
| $T_{cy}$ | cycle time | | 30 | – | 39 | ns |

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---|---|---|---|---|---|---|
| **BST interface;** see Fig.6 | | | | | | |
| $T_{cy(BST)}$ | BST cycle time | | – | 1 | – | µs |
| $t_{su(i)(BST)}$ | input set-up time | | 3 | – | – | ns |
| $t_{h(i)(BST)}$ | input hold time | | 6 | – | – | ns |
| $t_{h(o)(BST)}$ | output hold time | | 4 | – | – | ns |
| $t_{d(o)(BST)}$ | output delay | | – | – | 30 | ns |
| **SNERT interface;** see Fig.7 | | | | | | |
| $t_{SNRST(H)}$ | SNRST pulse HIGH time | | 500 | – | – | ns |
| $t_{d(SNRST-SNCL)}$ | delay SNRST pulse to SNCL LOW time | | 200 | – | – | ns |
| $T_{cy(SNCL)}$ | SNCL cycle time | | 0.5 | – | 1 | µs |
| $t_{su(i)(SNCL)}$ | input set-up time to SNCL | | 53 | – | – | ns |
| $t_{h(i)(SNCL)}$ | input hold time to SNCL | | 10 | – | – | ns |
| $t_{h(o)}$ | output hold time | | 30 | – | – | ns |
| $t_{d(o)}$ | output delay | | – | – | 330 | ns |
| $t_{o(en)}$ | output enable time | | 210 | – | – | ns |

**Notes**

1. All inputs except inputs with internal pull-up or pull-down resistor. These inputs have an absolute leakage current of maximum 50 µA.

2. Timing characteristics are measured with $C_L$ = 15 pF.

3. All inputs except SNERT interface inputs, CLK32 input and BST/TEST inputs.
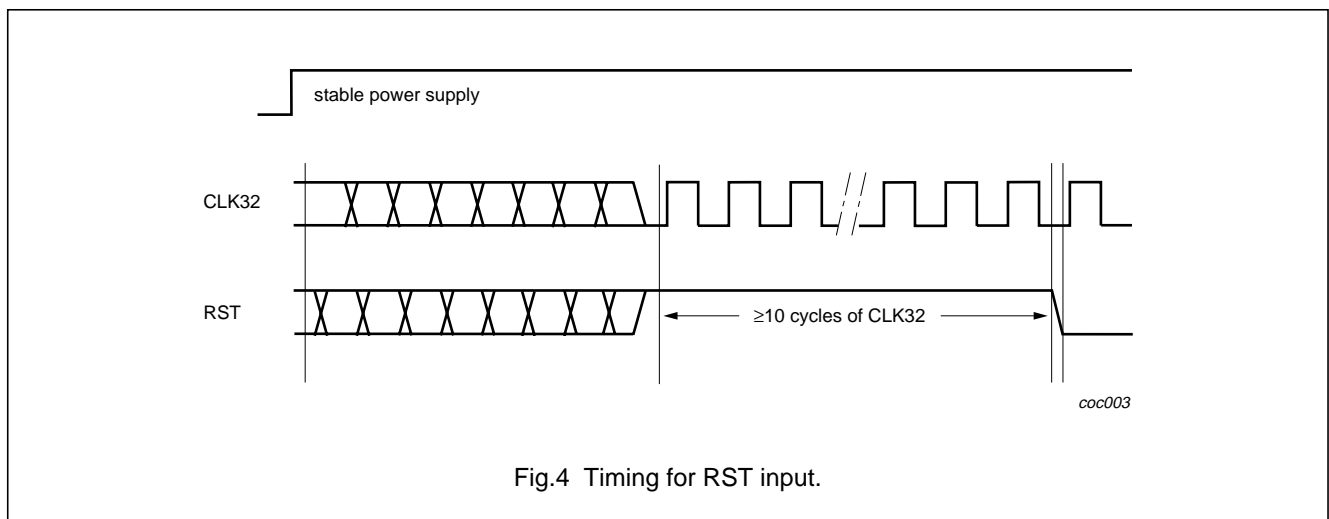


Fig.4  Timing for RST input.

Field and line rate converter with noise
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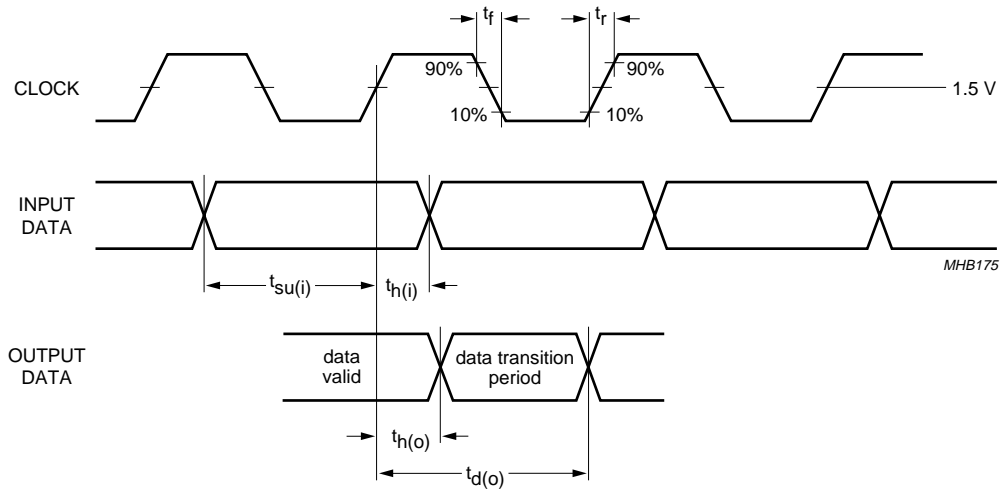
SAA4998H



Fig.5  Data input/output timing diagram.
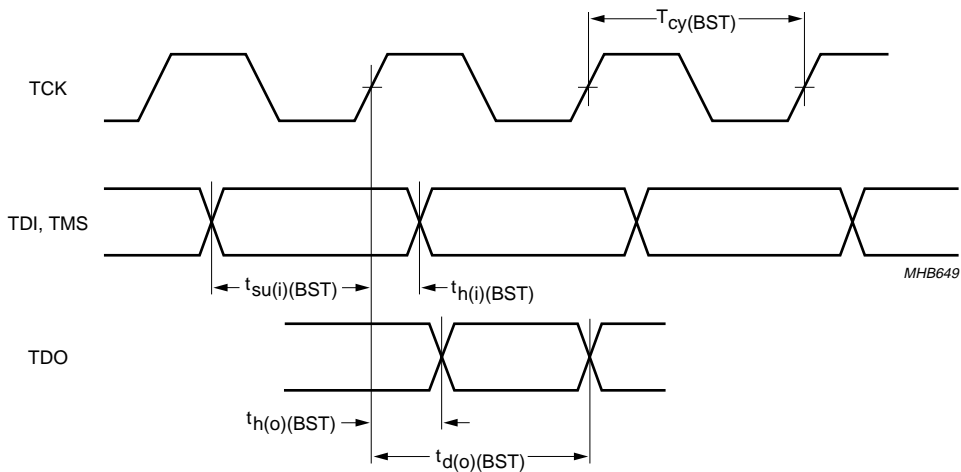


Fig.6  Boundary scan test interface timing diagram.

Field and line rate converter with noise
reduction and embedded memory
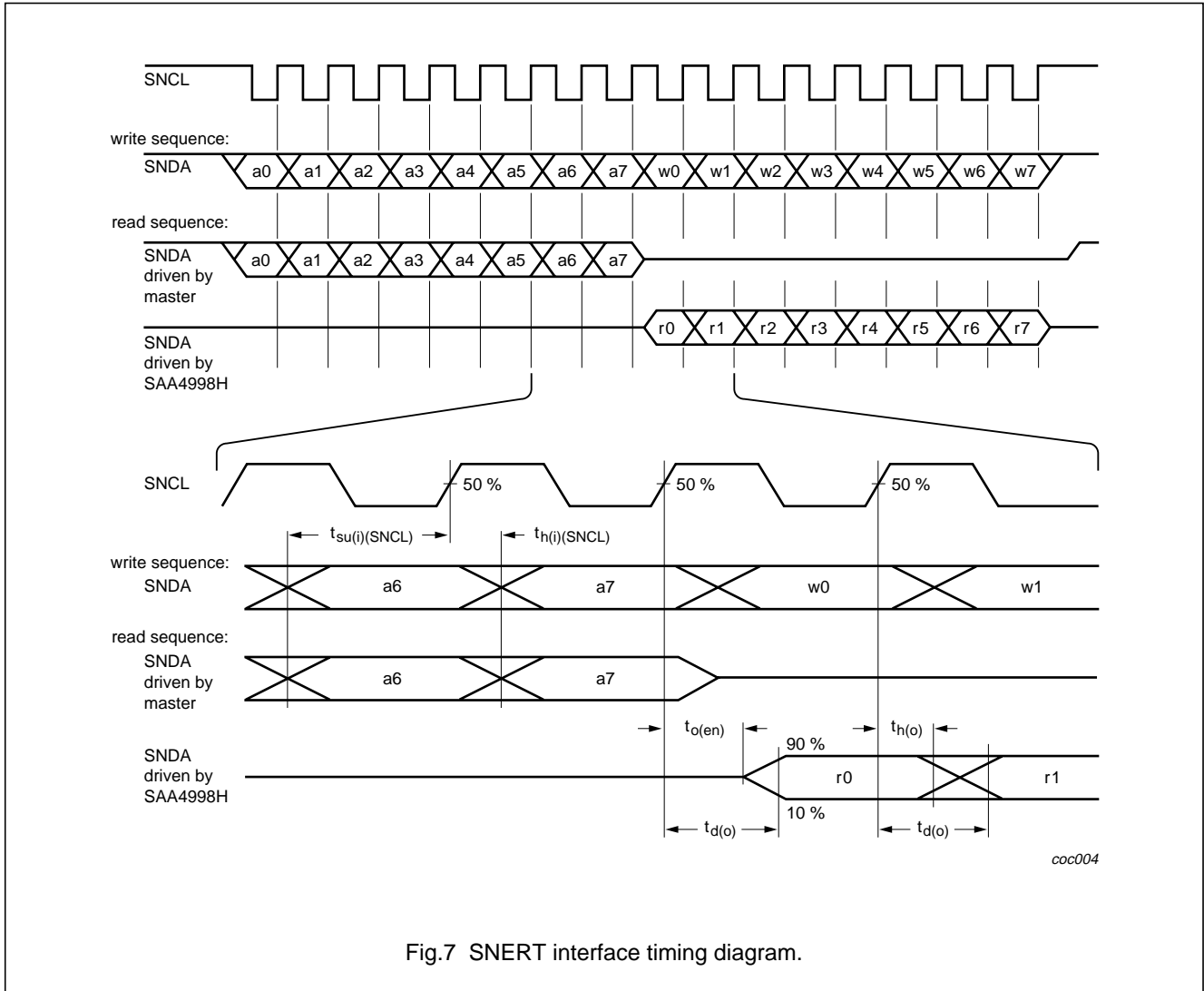
SAA4998H



Fig.7  SNERT interface timing diagram.

Field and line rate converter with noise
reduction and embedded memory                                        SAA4998H

**Table 1**   YUV formats

| I/O PIN[1] | FORMAT[2][3] | | | | | | | |
|---|---|---|---|---|---|---|---|---|
| | 4 : 1 : 1 | | | | 4 : 2 : 2 | | 4 : 2 : 2 DPCM | |
| Yx7 | Y07 | Y17 | Y27 | Y37 | Y07 | Y17 | Y07 | Y17 |
| Yx6 | Y06 | Y16 | Y26 | Y36 | Y06 | Y16 | Y06 | Y16 |
| Yx5 | Y05 | Y15 | Y25 | Y35 | Y05 | Y15 | Y05 | Y15 |
| Yx4 | Y04 | Y14 | Y24 | Y34 | Y04 | Y14 | Y04 | Y14 |
| Yx3 | Y03 | Y13 | Y23 | Y33 | Y03 | Y13 | Y03 | Y13 |
| Yx2 | Y02 | Y12 | Y22 | Y32 | Y02 | Y12 | Y02 | Y12 |
| Yx1 | Y01 | Y11 | Y21 | Y31 | Y01 | Y11 | Y01 | Y11 |
| Yx0 | Y00 | Y10 | Y20 | Y30 | Y00 | Y10 | Y00 | Y10 |
| UVx7 | U07 | U05 | U03 | U01 | U07 | V07 | UC03 | VC03 |
| UVx6 | U06 | U04 | U02 | U00 | U06 | V06 | UC02 | VC02 |
| UVx5 | V07 | V05 | V03 | V01 | U05 | V05 | UC01 | VC01 |
| UVx4 | V06 | V04 | V02 | V00 | U04 | V04 | UC00 | VC00 |
| UVx3 | X | X | X | X | U03 | V03 | X | X |
| UVx2 | X | X | X | X | U02 | V02 | X | X |
| UVx1 | X | X | X | X | U01 | V01 | X | X |
| UVx0 | X | X | X | X | U00 | V00 | X | X |

**Notes**

1. Digit x refers to different I/O buses:

   a)  A = input from 1st field memory

   b)  F = main output

   c)  G = 2nd output for matrix purposes.

2. The first index digit defines the sample number and the second defines the bit number.

3. X = don't care or not available.

Field and line rate converter with noise
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**SAA4998H**

## 11 PACKAGE OUTLINE

**QFP100: plastic quad flat package; 100 leads (lead length 1.95 mm); body 14 x 20 x 2.8 mm** **SOT317-2**
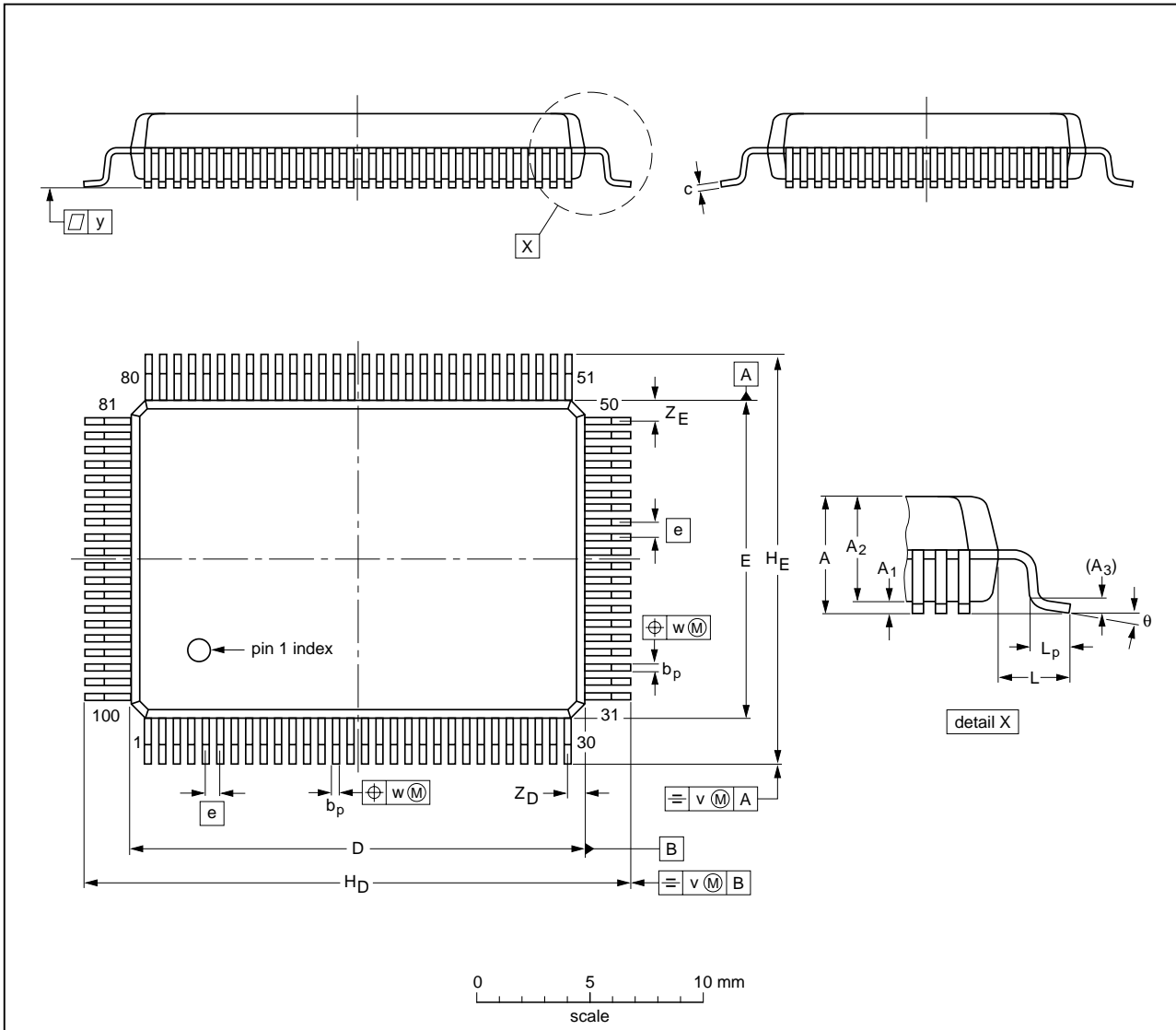


**DIMENSIONS (mm are the original dimensions)**

| UNIT | A max. | A₁ | A₂ | A₃ | bₚ | c | D(1) | E(1) | e | H_D | H_E | L | Lₚ | v | w | y | Z_D(1) | Z_E(1) | θ |
|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|
| mm | 3.2 | 0.25 0.05 | 2.90 2.65 | 0.25 | 0.40 0.25 | 0.25 0.14 | 20.1 19.9 | 14.1 13.9 | 0.65 | 24.2 23.6 | 18.2 17.6 | 1.95 | 1.0 0.6 | 0.2 | 0.15 | 0.1 | 0.8 0.4 | 1.0 0.6 | 7° 0° |

**Note**

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

| OUTLINE VERSION | REFERENCES | | | | EUROPEAN PROJECTION | ISSUE DATE |
|---|---|---|---|---|---|---|
| | IEC | JEDEC | JEITA | | | |
| SOT317-2 | | MO-112 | | | | 99-12-27 03-02-25 |

## 12  SOLDERING

### 12.1  Introduction to soldering surface mount packages

This text gives a very brief insight to a complex technology. A more in-depth account of soldering ICs can be found in our *"Data Handbook IC26; Integrated Circuit Packages"* (document order number 9398 652 90011).

There is no soldering method that is ideal for all surface mount IC packages. Wave soldering can still be used for certain surface mount ICs, but it is not suitable for fine pitch SMDs. In these situations reflow soldering is recommended.

### 12.2  Reflow soldering

Reflow soldering requires solder paste (a suspension of fine solder particles, flux and binding agent) to be applied to the printed-circuit board by screen printing, stencilling or pressure-syringe dispensing before package placement. Driven by legislation and environmental forces the worldwide use of lead-free solder pastes is increasing.

Several methods exist for reflowing; for example, convection or convection/infrared heating in a conveyor type oven. Throughput times (preheating, soldering and cooling) vary between 100 and 200 seconds depending on heating method.

Typical reflow peak temperatures range from 215 to 270 °C depending on solder paste material. The top-surface temperature of the packages should preferably be kept:

- below 225 °C (SnPb process) or below 245 °C (Pb-free process)
  - for all BGA, HTSSON-T and SSOP-T packages
  - for packages with a thickness ≥ 2.5 mm
  - for packages with a thickness < 2.5 mm and a volume ≥ 350 $mm^3$ so called thick/large packages.
- below 240 °C (SnPb process) or below 260 °C (Pb-free process) for packages with a thickness < 2.5 mm and a volume < 350 $mm^3$ so called small/thin packages.

Moisture sensitivity precautions, as indicated on packing, must be respected at all times.

### 12.3  Wave soldering

Conventional single wave soldering is not recommended for surface mount devices (SMDs) or printed-circuit boards with a high component density, as solder bridging and non-wetting can present major problems.

To overcome these problems the double-wave soldering method was specifically developed.

If wave soldering is used the following conditions must be observed for optimal results:

- Use a double-wave soldering method comprising a turbulent wave with high upward pressure followed by a smooth laminar wave.
- For packages with leads on two sides and a pitch (e):
  - larger than or equal to 1.27 mm, the footprint longitudinal axis is **preferred** to be parallel to the transport direction of the printed-circuit board;
  - smaller than 1.27 mm, the footprint longitudinal axis **must** be parallel to the transport direction of the printed-circuit board.

The footprint must incorporate solder thieves at the downstream end.

- For packages with leads on four sides, the footprint must be placed at a 45° angle to the transport direction of the printed-circuit board. The footprint must incorporate solder thieves downstream and at the side corners.

During placement and before soldering, the package must be fixed with a droplet of adhesive. The adhesive can be applied by screen printing, pin transfer or syringe dispensing. The package can be soldered after the adhesive is cured.

Typical dwell time of the leads in the wave ranges from 3 to 4 seconds at 250 °C or 265 °C, depending on solder material applied, SnPb or Pb-free respectively.

A mildly-activated flux will eliminate the need for removal of corrosive residues in most applications.

### 12.4  Manual soldering

Fix the component by first soldering two diagonally-opposite end leads. Use a low voltage (24 V or less) soldering iron applied to the flat part of the lead. Contact time must be limited to 10 seconds at up to 300 °C.

When using a dedicated tool, all other leads can be soldered in one operation within 2 to 5 seconds between 270 and 320 °C.

**12.5   Suitability of surface mount IC packages for wave and reflow soldering methods**

| PACKAGE[1] | SOLDERING METHOD | |
|---|---|---|
| | **WAVE** | **REFLOW**[2] |
| BGA, HTSSON..T[3], LBGA, LFBGA, SQFP, SSOP..T[3], TFBGA, USON, VFBGA | not suitable | suitable |
| DHVQFN, HBCC, HBGA, HLQFP, HSO, HSOP, HSQFP, HSSON, HTQFP, HTSSOP, HVQFN, HVSON, SMS | not suitable[4] | suitable |
| PLCC[5], SO, SOJ | suitable | suitable |
| LQFP, QFP, TQFP | not recommended[5][6] | suitable |
| SSOP, TSSOP, VSO, VSSOP | not recommended[7] | suitable |
| CWQCCN..L[8], PMFP[9], WQCCN..L[8] | not suitable | not suitable |

**Notes**

1. For more detailed information on the BGA packages refer to the *"(LF)BGA Application Note"* (AN01026); order a copy from your Philips Semiconductors sales office.

2. All surface mount (SMD) packages are moisture sensitive. Depending upon the moisture content, the maximum temperature (with respect to time) and body size of the package, there is a risk that internal or external package cracks may occur due to vaporization of the moisture in them (the so called popcorn effect). For details, refer to the Drypack information in the *"Data Handbook IC26; Integrated Circuit Packages; Section: Packing Methods"*.

3. These transparent plastic packages are extremely sensitive to reflow soldering conditions and must on no account be processed through more than one soldering cycle or subjected to infrared reflow soldering with peak temperature exceeding 217 °C ± 10 °C measured in the atmosphere of the reflow oven. The package body peak temperature must be kept as low as possible.

4. These packages are not suitable for wave soldering. On versions with the heatsink on the bottom side, the solder cannot penetrate between the printed-circuit board and the heatsink. On versions with the heatsink on the top side, the solder might be deposited on the heatsink surface.

5. If wave soldering is considered, then the package must be placed at a 45° angle to the solder wave direction. The package footprint must incorporate solder thieves downstream and at the side corners.

6. Wave soldering is suitable for LQFP, TQFP and QFP packages with a pitch (e) larger than 0.8 mm; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.65 mm.

7. Wave soldering is suitable for SSOP, TSSOP, VSO and VSSOP packages with a pitch (e) equal to or larger than 0.65 mm; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.5 mm.

8. Image sensor packages in principle should not be soldered. They are mounted in sockets or delivered pre-mounted on flex foil. However, the image sensor package can be mounted by the client on a flex foil by using a hot bar soldering process. The appropriate soldering profile can be provided on request.

9. Hot bar or manual soldering is suitable for PMFP packages.

**12.6   Additional soldering information**

The package QFP100 (lead-free; SOT317GC11, subpackage of the SOT317-2) is granted the Moisture Sensitivity Level (MSL) 3.

Soldering temperature of > 215 °C is recommended or RMA flux.

## 13 DATA SHEET STATUS

| LEVEL | DATA SHEET STATUS[1] | PRODUCT STATUS[2][3] | DEFINITION |
|---|---|---|---|
| I | Objective data | Development | This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice. |
| II | Preliminary data | Qualification | This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product. |
| III | Product data | Production | This data sheet contains data from the product specification. Philips Semiconductors reserves the right to make changes at any time in order to improve the design, manufacturing and supply. Relevant changes will be communicated via a Customer Product/Process Change Notification (CPCN). |

**Notes**

1. Please consult the most recently issued data sheet before initiating or completing a design.

2. The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL http://www.semiconductors.philips.com.

3. For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

## 14 DEFINITIONS

**Short-form specification** — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

**Limiting values definition** — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

**Application information** — Applications that are described herein for any of these products are for illustrative purposes only. Philips Semiconductors make no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

## 15 DISCLAIMERS

**Life support applications** — These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips Semiconductors customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips Semiconductors for any damages resulting from such application.

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